

# 74HC14-Q100; 74HCT14-Q100

Hex inverting Schmitt trigger

Rev. 4 — 19 April 2013

Product data sheet

## 1. General description

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The 74HC14-Q100; 74HCT14-Q100 is a high-speed Si-gate CMOS device and is pin compatible with Low-power Schottky TTL (LSTTL). It is specified in compliance with JEDEC standard No. 7A.

The 74HC14-Q100; 74HCT14-Q100 provides six inverting buffers with Schmitt-trigger action. They are capable of transforming slowly changing input signals into sharply defined, jitter-free output signals.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

## 2. Features and benefits

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- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
  - ◆ Specified from  $-40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$  and from  $-40\text{ }^{\circ}\text{C}$  to  $+125\text{ }^{\circ}\text{C}$
- Low-power dissipation
- ESD protection:
  - ◆ MIL-STD-883, method 3015 exceeds 2000 V
  - ◆ HBM JESD22-A114F exceeds 2000 V
  - ◆ MM JESD22-A115-A exceeds 200 V (C = 200 pF, R = 0  $\Omega$ )
- Multiple package options

## 3. Applications

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- Wave and pulse shapers
- Astable multivibrators
- Monostable multivibrators

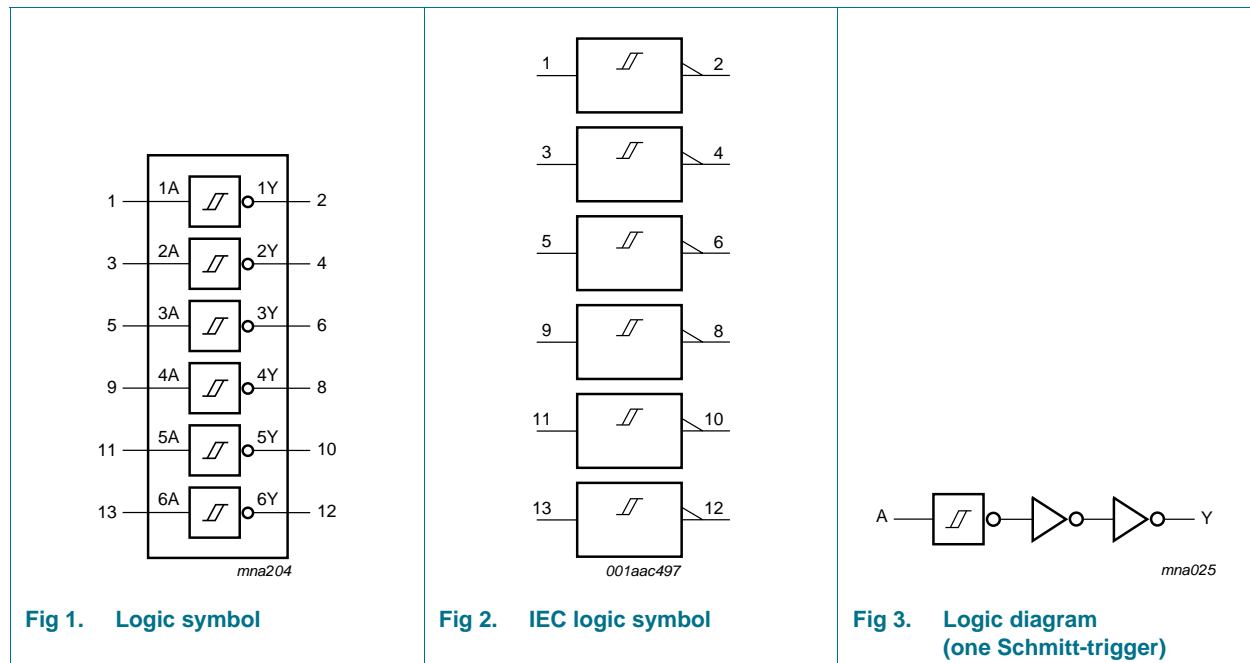


## 4. Ordering information

Table 1. Ordering information

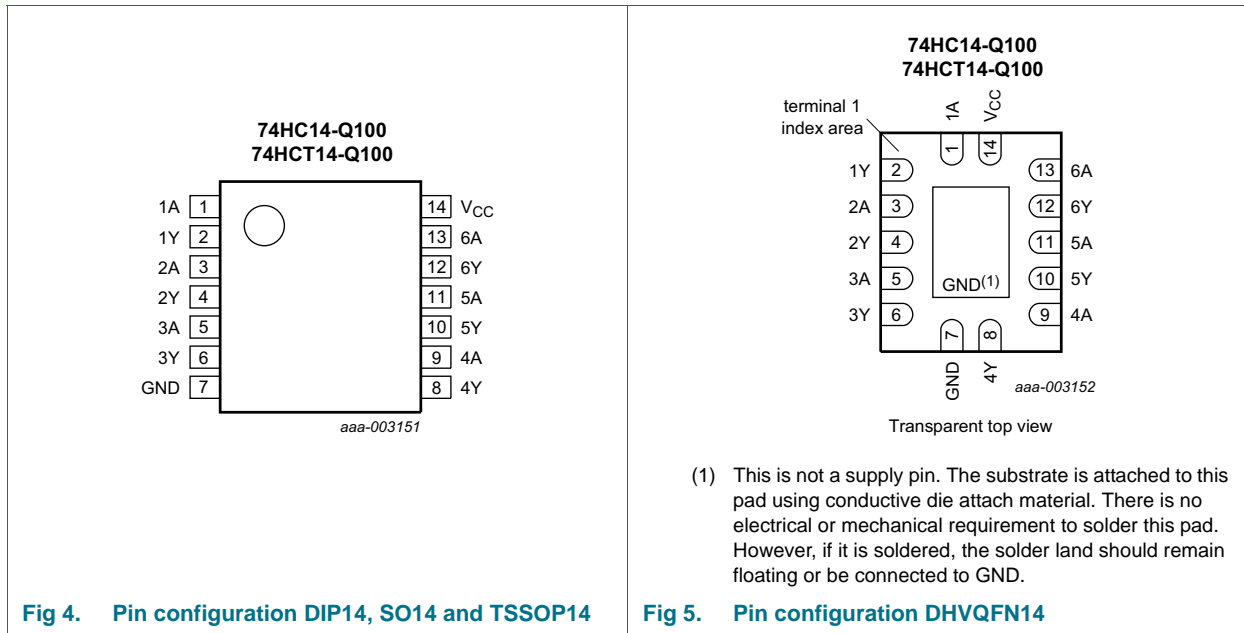
Type number	Package			Version
	Temperature range	Name	Description	
74HC14N-Q100	-40 °C to +125 °C	DIP14	plastic dual in-line package; 14 leads (300 mil)	SOT27-1
74HC14D-Q100	-40 °C to +125 °C	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1
74HCT14D-Q100				
74HC14PW-Q100	-40 °C to +125 °C	TSSOP14	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	SOT402-1
74HCT14PW-Q100				
74HC14BQ-Q100	-40 °C to +125 °C	DHVQFN14	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 × 3 × 0.85 mm	SOT762-1
74HCT14BQ-Q100				

## 5. Functional diagram



## 6. Pinning information

### 6.1 Pinning



### 6.2 Pin description

**Table 2. Pin description**

Symbol	Pin	Description
1A to 6A	1, 3, 5, 9, 11, 13	data input 1
1Y to 6Y	2, 4, 6, 8, 10, 12	data output 1
GND	7	ground (0 V)
V <sub>CC</sub>	14	supply voltage

## 7. Functional description

**Table 3. Function table<sup>[1]</sup>**

Input	Output
nA	nY
L	H
H	L

[1] H = HIGH voltage level;  
L = LOW voltage level.

## 8. Limiting values

**Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+7	V
$I_{IK}$	input clamping current	$V_I < -0.5\text{ V}$ or $V_I > V_{CC} + 0.5\text{ V}$	[1]	-	$\pm 20$ mA
$I_{OK}$	output clamping current	$V_O < -0.5\text{ V}$ or $V_O > V_{CC} + 0.5\text{ V}$	[1]	-	$\pm 20$ mA
$I_O$	output current	$-0.5\text{ V} < V_O < V_{CC} + 0.5\text{ V}$	-	$\pm 25$	mA
$I_{CC}$	supply current		-	50	mA
$I_{GND}$	ground current		-50	-	mA
$T_{stg}$	storage temperature		-65	+150	°C
$P_{tot}$	total power dissipation		[2]		
	DIP14 package		-	750	mW
	SO14, TSSOP14 and DHVQFN14 packages		-	500	mW

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] For DIP14 package:  $P_{tot}$  derates linearly with 12 mW/K above 70 °C.

For SO14 package:  $P_{tot}$  derates linearly with 8 mW/K above 70 °C.

For TSSOP14 packages:  $P_{tot}$  derates linearly with 5.5 mW/K above 60 °C.

For DHVQFN14 packages:  $P_{tot}$  derates linearly with 4.5 mW/K above 60 °C.

## 9. Recommended operating conditions

**Table 5. Recommended operating conditions**

Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	74HC14-Q100			74HCT14-Q100			Unit
			Min	Typ	Max	Min	Typ	Max	
$V_{CC}$	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
$V_I$	input voltage		0	-	$V_{CC}$	0	-	$V_{CC}$	V
$V_O$	output voltage		0	-	$V_{CC}$	0	-	$V_{CC}$	V
$T_{amb}$	ambient temperature		-40	+25	+125	-40	+25	+125	°C

## 10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T <sub>amb</sub> = 25 °C			T <sub>amb</sub> = -40 °C to +85 °C		T <sub>amb</sub> = -40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	Min	Max	
<b>74HC14-Q100</b>										
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>T+</sub> or V <sub>T-</sub>								
		I <sub>O</sub> = -20 μA; V <sub>CC</sub> = 2.0 V	1.9	2.0	-	1.9	-	1.9	-	V
		I <sub>O</sub> = -20 μA; V <sub>CC</sub> = 4.5 V	4.4	4.5	-	4.4	-	4.4	-	V
		I <sub>O</sub> = -20 μA; V <sub>CC</sub> = 6.0 V	5.9	6.0	-	5.9	-	5.9	-	V
		I <sub>O</sub> = -4.0 mA; V <sub>CC</sub> = 4.5 V	3.98	4.32	-	3.84	-	3.7	-	V
		I <sub>O</sub> = -5.2 mA; V <sub>CC</sub> = 6.0 V	5.48	5.81	-	5.34	-	5.2	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>T+</sub> or V <sub>T-</sub>								
		I <sub>O</sub> = 20 μA; V <sub>CC</sub> = 2.0 V	-	0	0.1	-	0.1	-	0.1	V
		I <sub>O</sub> = 20 μA; V <sub>CC</sub> = 4.5 V	-	0	0.1	-	0.1	-	0.1	V
		I <sub>O</sub> = 20 μA; V <sub>CC</sub> = 6.0 V	-	0	0.1	-	0.1	-	0.1	V
		I <sub>O</sub> = 4.0 mA; V <sub>CC</sub> = 4.5 V	-	0.15	0.26	-	0.33	-	0.4	V
		I <sub>O</sub> = 5.2 mA; V <sub>CC</sub> = 6.0 V	-	0.16	0.26	-	0.33	-	0.4	V
I <sub>I</sub>	input leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 6.0 V	-	-	±0.1	-	±1.0	-	±1.0	μA
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 6.0 V	-	-	2.0	-	20	-	40	μA
C <sub>I</sub>	input capacitance		-	3.5	-	-	-	-	-	pF
<b>74HCT14-Q100</b>										
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>T+</sub> or V <sub>T-</sub> ; V <sub>CC</sub> = 4.5 V								
		I <sub>O</sub> = -20 μA	4.4	4.5	-	4.4	-	4.4	-	V
		I <sub>O</sub> = -4.0 mA	3.98	4.32	-	3.84	-	3.7	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>T+</sub> or V <sub>T-</sub> ; V <sub>CC</sub> = 4.5 V								
		I <sub>O</sub> = 20 μA;	-	0	0.1	-	0.1	-	0.1	V
		I <sub>O</sub> = 4.0 mA;	-	0.15	0.26	-	0.33	-	0.4	V
I <sub>I</sub>	input leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 5.5 V	-	-	±0.1	-	±1.0	-	±1.0	μA
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 5.5 V	-	-	2.0	-	20	-	40	μA
ΔI <sub>CC</sub>	additional supply current	per input pin; V <sub>I</sub> = V <sub>CC</sub> - 2.1 V; other pins at V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 4.5 V to 5.5 V	-	30	108	-	135	-	147	μA
C <sub>I</sub>	input capacitance		-	3.5	-	-	-	-	-	pF

## 11. Dynamic characteristics

**Table 7. Dynamic characteristics**

$GND = 0\text{ V}$ ;  $C_L = 50\text{ pF}$ ; for load circuit see [Figure 7](#).

Symbol	Parameter	Conditions	$T_{\text{amb}} = 25\text{ °C}$			$T_{\text{amb}} = -40\text{ °C to }+125\text{ °C}$		Unit
			Min	Typ	Max	Max (85 °C)	Max (125 °C)	
<b>74HC14-Q100</b>								
$t_{\text{pd}}$	propagation delay	nA to nY; see <a href="#">Figure 6</a> <a href="#">[1]</a>						
		$V_{\text{CC}} = 2.0\text{ V}$	-	41	125	155	190	ns
		$V_{\text{CC}} = 4.5\text{ V}$	-	15	25	31	38	ns
		$V_{\text{CC}} = 5.0\text{ V}$ ; $C_L = 15\text{ pF}$ $V_{\text{CC}} = 6.0\text{ V}$	-	12	-	-	-	ns
$t_t$	transition time	see <a href="#">Figure 6</a> <a href="#">[2]</a>						
		$V_{\text{CC}} = 2.0\text{ V}$	-	19	75	95	110	ns
		$V_{\text{CC}} = 4.5\text{ V}$	-	7	15	19	22	ns
		$V_{\text{CC}} = 6.0\text{ V}$	-	6	13	15	19	ns
$C_{\text{PD}}$	power dissipation capacitance	per package; $V_I = GND$ to $V_{\text{CC}}$ <a href="#">[3]</a>	-	7	-	-	-	pF
<b>74HCT14-Q100</b>								
$t_{\text{pd}}$	propagation delay	nA to nY; see <a href="#">Figure 6</a> <a href="#">[1]</a>						
		$V_{\text{CC}} = 4.5\text{ V}$	-	20	34	43	51	ns
		$V_{\text{CC}} = 5.0\text{ V}$ ; $C_L = 15\text{ pF}$	-	17	-	-	-	ns
$t_t$	transition time	$V_{\text{CC}} = 4.5\text{ V}$ ; see <a href="#">Figure 6</a> <a href="#">[2]</a>	-	7	15	19	22	ns
$C_{\text{PD}}$	power dissipation capacitance	per package; $V_I = GND$ to $V_{\text{CC}} - 1.5\text{ V}$ <a href="#">[3]</a>	-	8	-	-	-	pF

[1]  $t_{\text{pd}}$  is the same as  $t_{\text{PHL}}$  and  $t_{\text{PLH}}$ .

[2]  $t_t$  is the same as  $t_{\text{THL}}$  and  $t_{\text{TLH}}$ .

[3]  $C_{\text{PD}}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu\text{W}$ ):

$$P_D = C_{\text{PD}} \times V_{\text{CC}}^2 \times f_i \times N + \sum (C_L \times V_{\text{CC}}^2 \times f_o) \text{ where:}$$

$f_i$  = input frequency in MHz;

$f_o$  = output frequency in MHz;

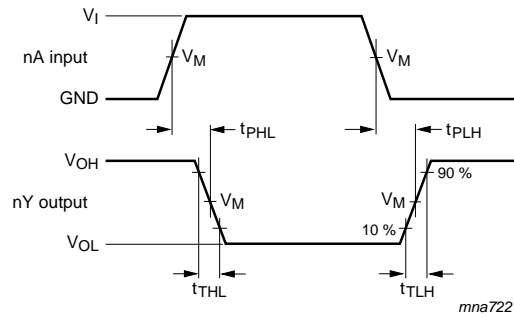
$C_L$  = output load capacitance in pF;

$V_{\text{CC}}$  = supply voltage in V;

$N$  = number of inputs switching;

$\sum (C_L \times V_{\text{CC}}^2 \times f_o)$  = sum of outputs.

## 12. Waveforms



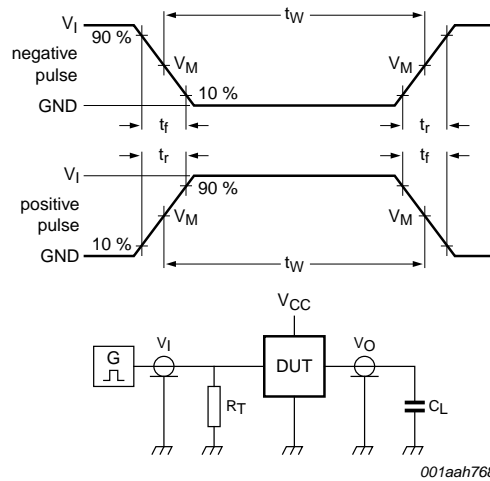
Measurement points are given in [Table 8](#).

$V_{OL}$  and  $V_{OH}$  are typical voltage output levels that occur with the output load.

**Fig 6. Input to output propagation delays**

**Table 8. Measurement points**

Type	Input	Output		
	$V_M$	$V_M$	$V_X$	$V_Y$
74HC14-Q100	$0.5V_{CC}$	$0.5V_{CC}$	$0.1V_{CC}$	$0.9V_{CC}$
74HCT14-Q100	1.3 V	1.3 V	$0.1V_{CC}$	$0.9V_{CC}$



Test data is given in [Table 9](#).

Definitions test circuit:

$R_T$  = termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

$C_L$  = load capacitance including jig and probe capacitance.

**Fig 7. Test circuit for measuring switching times**

**Table 9. Test data**

Type	Input		Load	Test
	$V_I$	$t_r, t_f$	$C_L$	
74HC14-Q100	$V_{CC}$	6.0 ns	15 pF, 50 pF	$t_{PLH}, t_{PHL}$
74HCT14-Q100	3.0 V	6.0 ns	15 pF, 50 pF	$t_{PLH}, t_{PHL}$

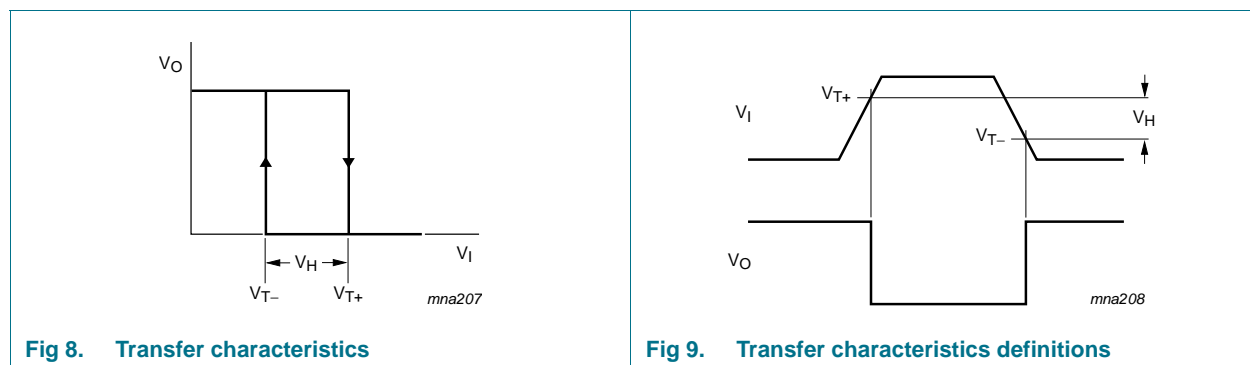
## 13. Transfer characteristics

**Table 10. Transfer characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); see [Figure 8](#) and [Figure 9](#).

Symbol	Parameter	Conditions	$T_{amb} = 25\text{ }^\circ\text{C}$			$T_{amb} = -40\text{ }^\circ\text{C}$ to $+85\text{ }^\circ\text{C}$		$T_{amb} = -40\text{ }^\circ\text{C}$ to $+125\text{ }^\circ\text{C}$		Unit
			Min	Typ	Max	Min	Max	Min	Max	
<b>74HC14-Q100</b>										
$V_{T+}$	positive-going threshold voltage	$V_{CC} = 2.0\text{ V}$	0.7	1.18	1.5	0.7	1.5	0.7	1.5	V
		$V_{CC} = 4.5\text{ V}$	1.7	2.38	3.15	1.7	3.15	1.7	3.15	V
		$V_{CC} = 6.0\text{ V}$	2.1	3.14	4.2	2.1	4.2	2.1	4.2	V
$V_{T-}$	negative-going threshold voltage	$V_{CC} = 2.0\text{ V}$	0.3	0.52	0.9	0.3	0.9	0.3	0.9	V
		$V_{CC} = 4.5\text{ V}$	0.9	1.4	2.0	0.9	2.0	0.9	2.0	V
		$V_{CC} = 6.0\text{ V}$	1.2	1.89	2.6	1.2	2.6	1.2	2.6	V
$V_H$	hysteresis voltage	$V_{CC} = 2.0\text{ V}$	0.2	0.66	1.0	0.2	1.0	0.2	1.0	V
		$V_{CC} = 4.5\text{ V}$	0.4	0.98	1.4	0.4	1.4	0.4	1.4	V
		$V_{CC} = 6.0\text{ V}$	0.6	1.25	1.6	0.6	1.6	0.6	1.6	V
<b>74HCT14-Q100</b>										
$V_{T+}$	positive-going threshold voltage	$V_{CC} = 4.5\text{ V}$	1.2	1.41	1.9	1.2	1.9	1.2	1.9	V
		$V_{CC} = 5.5\text{ V}$	1.4	1.59	2.1	1.4	2.1	1.4	2.1	V
$V_{T-}$	negative-going threshold voltage	$V_{CC} = 4.5\text{ V}$	0.5	0.85	1.2	0.5	1.2	0.5	1.2	V
		$V_{CC} = 5.5\text{ V}$	0.6	0.99	1.4	0.6	1.4	0.6	1.4	V
$V_H$	hysteresis voltage	$V_{CC} = 4.5\text{ V}$	0.4	0.56	-	0.4	-	0.4	-	V
		$V_{CC} = 5.5\text{ V}$	0.4	0.6	-	0.4	-	0.4	-	V

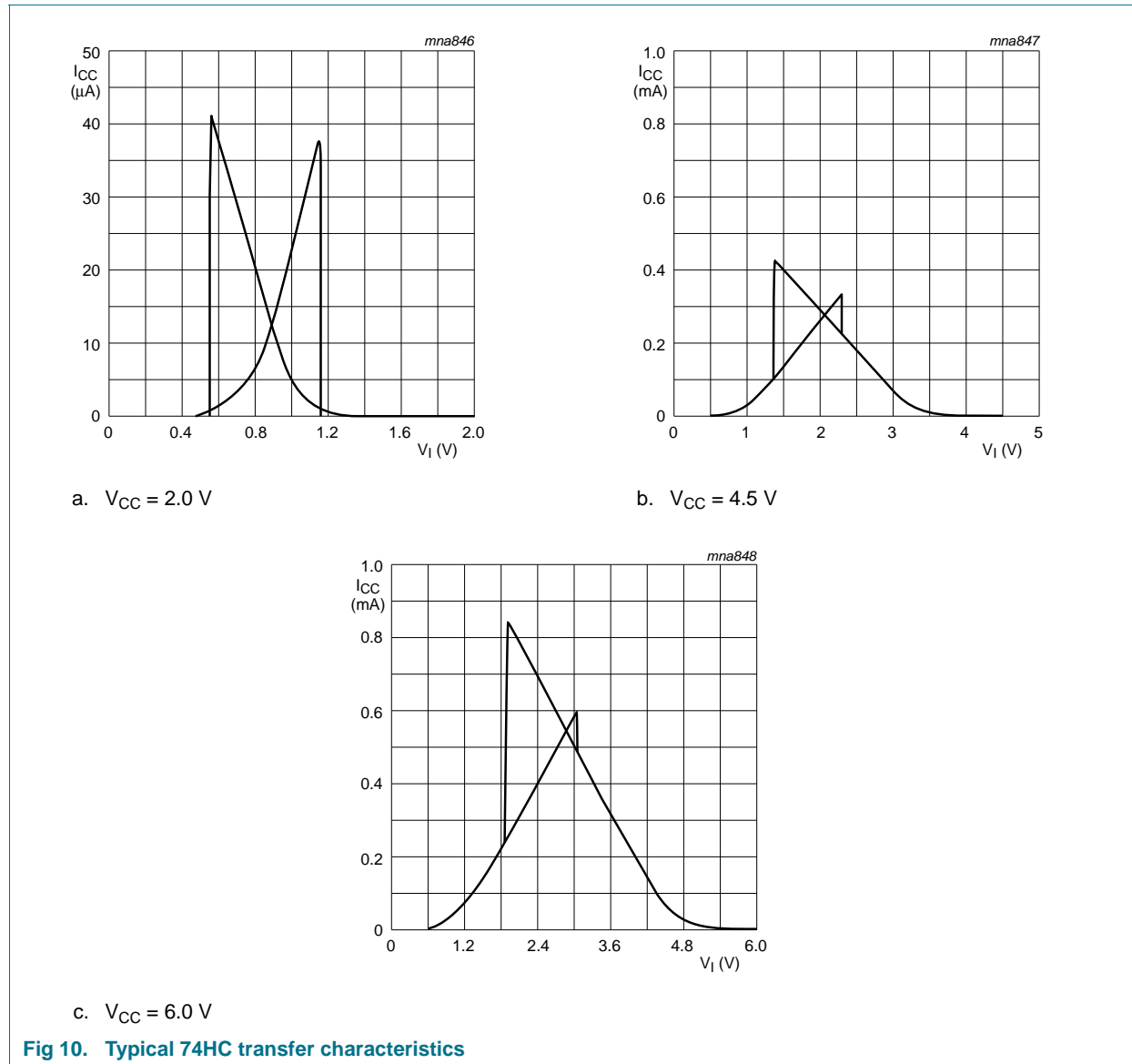
## 14. Transfer characteristics waveforms



**Fig 8. Transfer characteristics**

**Fig 9. Transfer characteristics definitions**





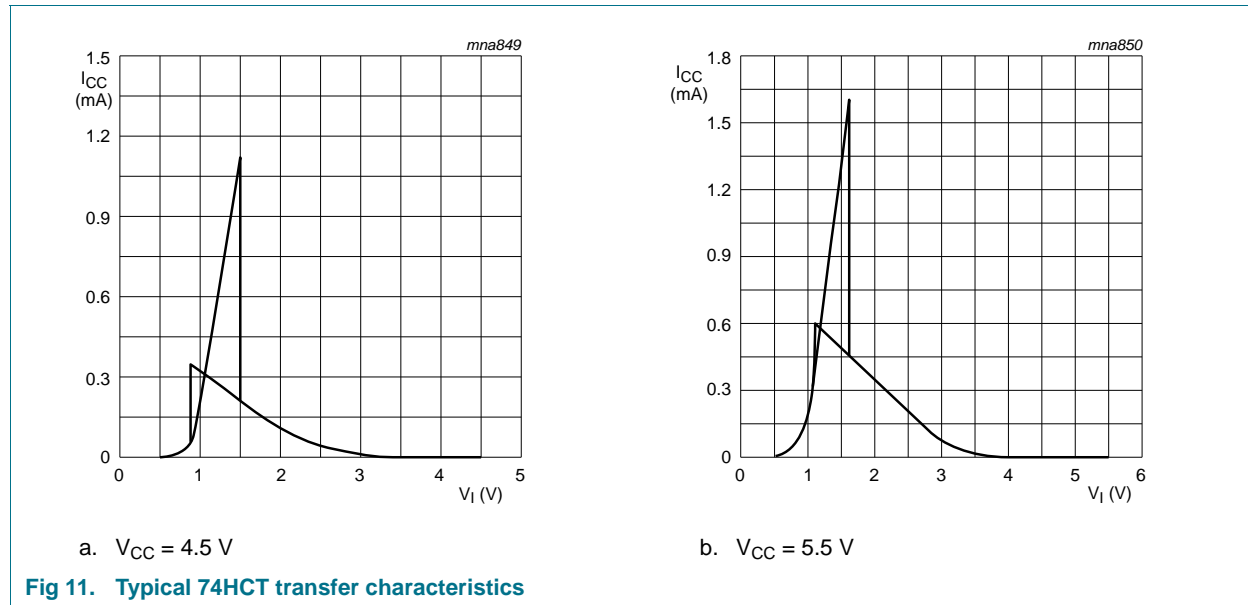


Fig 11. Typical 74HCT transfer characteristics

## 15. Application information

The slow input rise and fall times cause additional power dissipation, this can be calculated using the following formula:

$P_{add} = f_i \times (t_r \times \Delta I_{CC(AV)} + t_f \times \Delta I_{CC(AV)}) \times V_{CC}$  where:

$P_{add}$  = additional power dissipation ( $\mu$ W);

$f_i$  = input frequency (MHz);

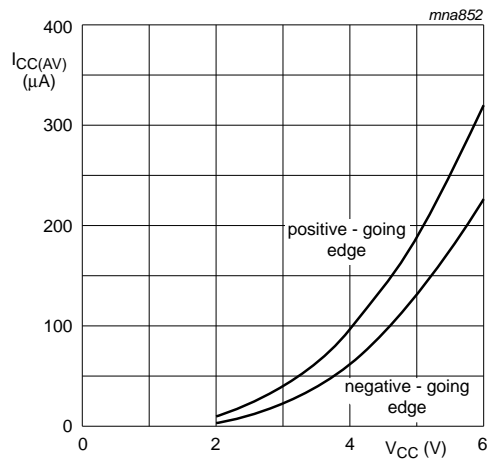
$t_r$  = rise time (ns); 10 % to 90 %;

$t_f$  = fall time (ns); 90 % to 10 %;

$\Delta I_{CC(AV)}$  = average additional supply current ( $\mu$ A).

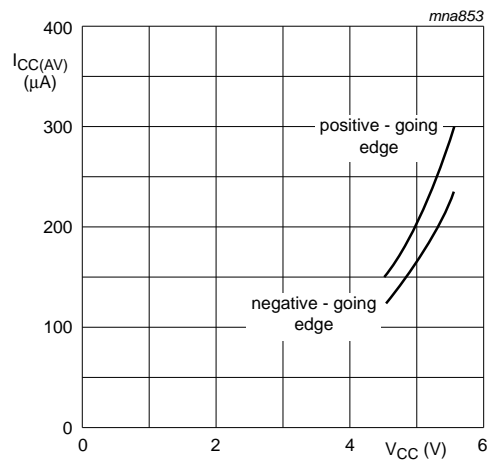
Average  $\Delta I_{CC(AV)}$  differs with positive or negative input transitions, as shown in [Figure 12](#) and [Figure 13](#).

An example of a relaxation circuit using the 74HC14-Q100; 74HCT14-Q100 is shown in [Figure 14](#).



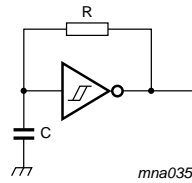
- (1) Positive-going edge.
- (2) Negative-going edge.

**Fig 12. Average additional supply current as a function of V<sub>CC</sub> for 74HC14-Q100; linear change of V<sub>I</sub> between 0.1V<sub>CC</sub> to 0.9V<sub>CC</sub>.**



- (1) Positive-going edge.
- (2) Negative-going edge.

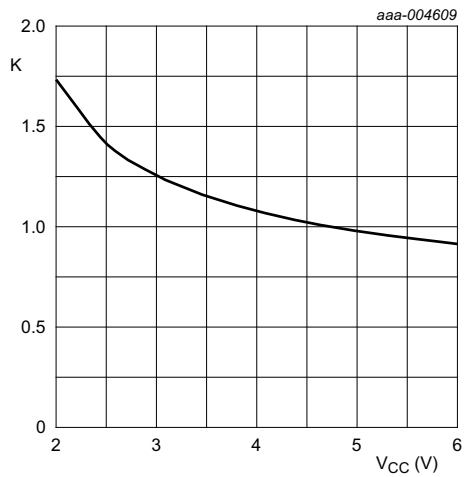
**Fig 13. Average additional supply current as a function of V<sub>CC</sub> for 74HCT14-Q100; linear change of V<sub>I</sub> between 0.1V<sub>CC</sub> to 0.9V<sub>CC</sub>.**



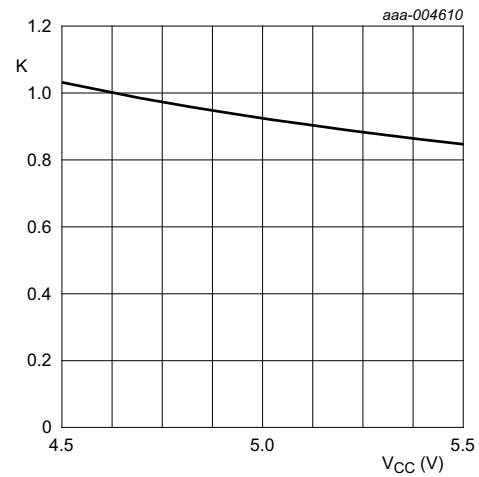
For 74HC14-Q100 and 74HCT14-Q100:  $f = \frac{1}{T} \approx \frac{1}{K \times RC}$

For K-factor see [Figure 15](#)

**Fig 14. Relaxation oscillator**



K-factor for 74HC14-Q100



K-factor for 74HCT14-Q100

**Fig 15. Typical K-factor for relaxation oscillator**

## 16. Package outline

DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1

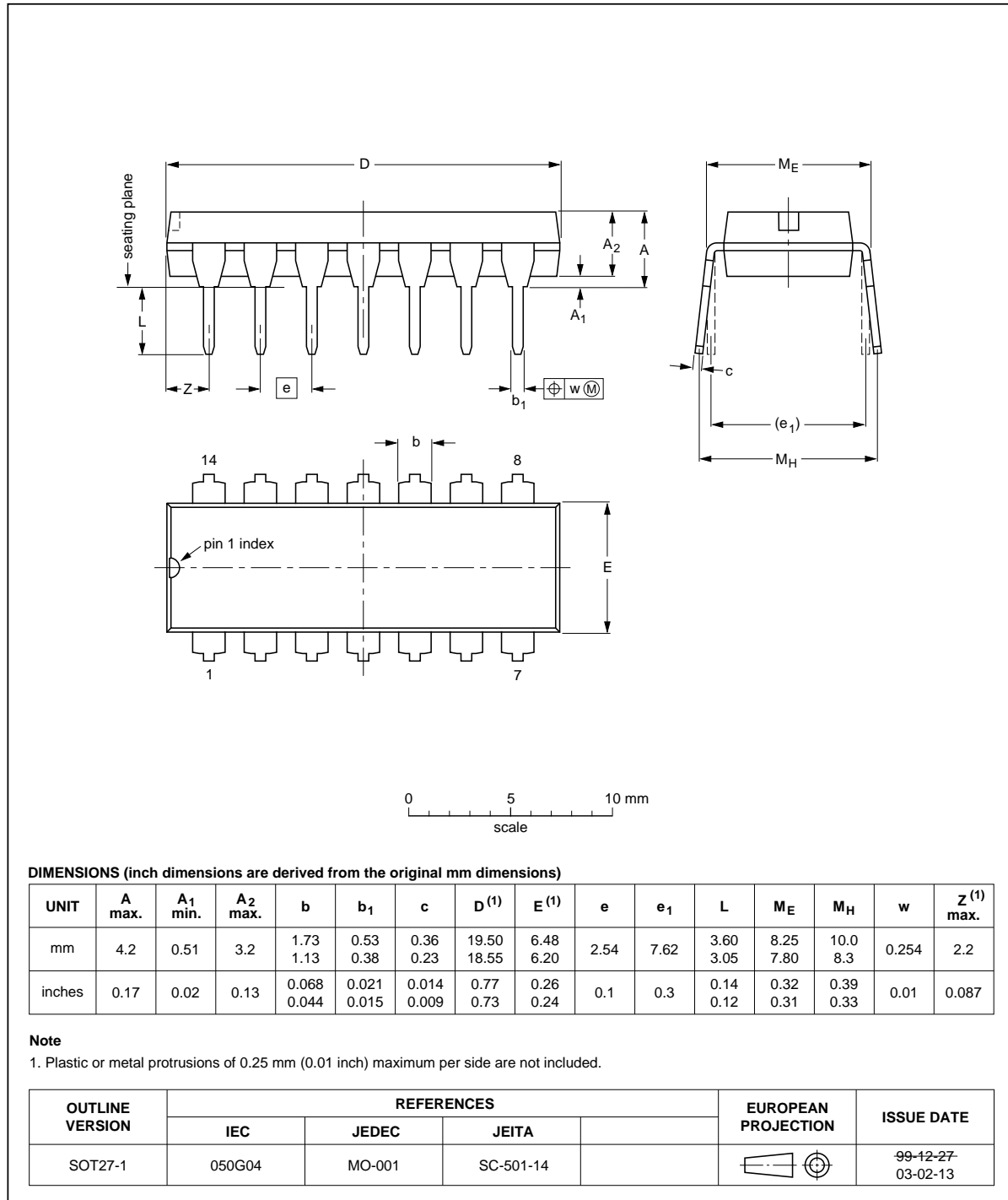


Fig 16. Package outline SOT27-1 (DIP14)

SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1

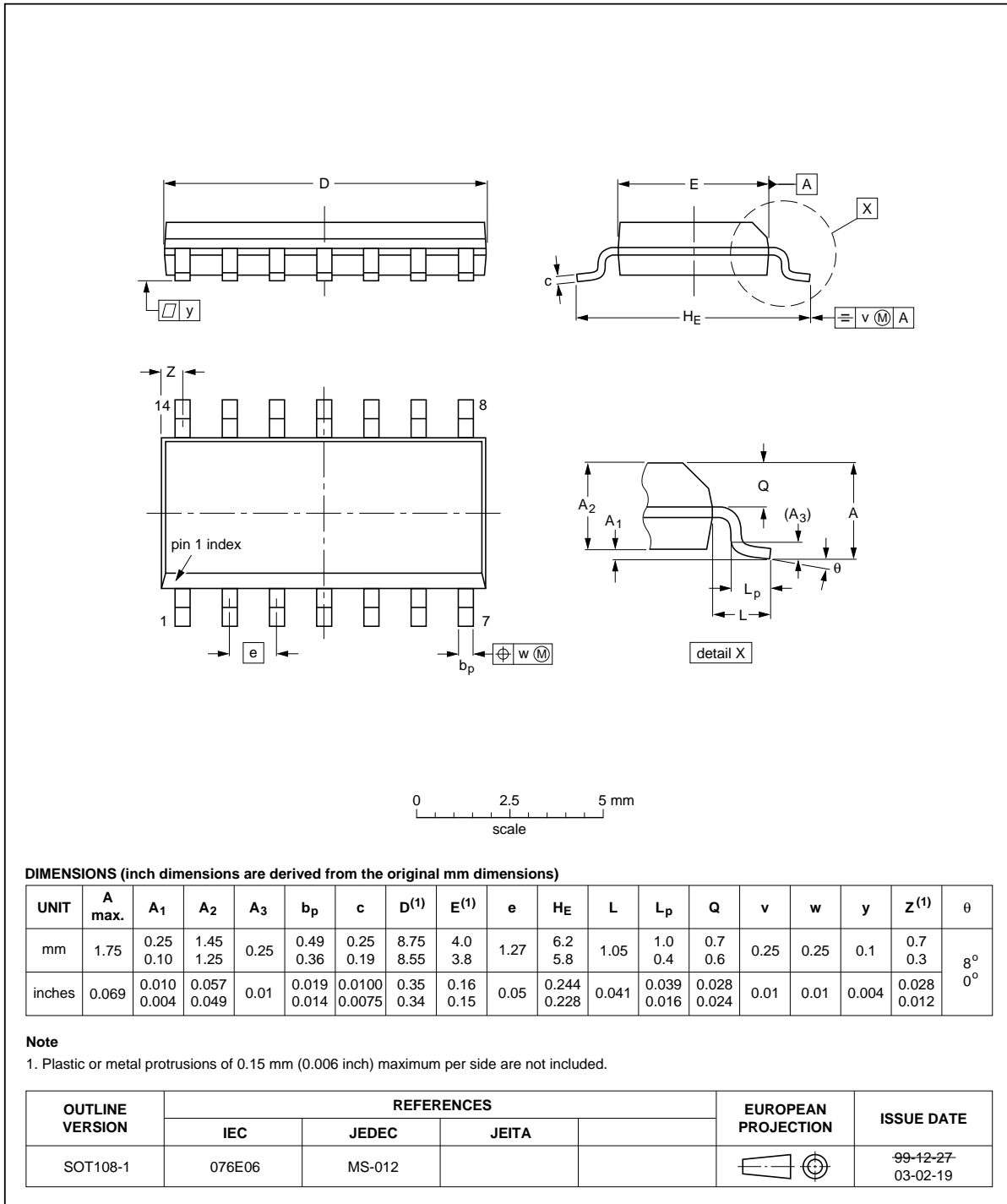


Fig 17. Package outline SOT108-1 (SO14)

TSSOP14: plastic thin shrink small outline package; 14 leads; body width 4.4 mm

SOT402-1

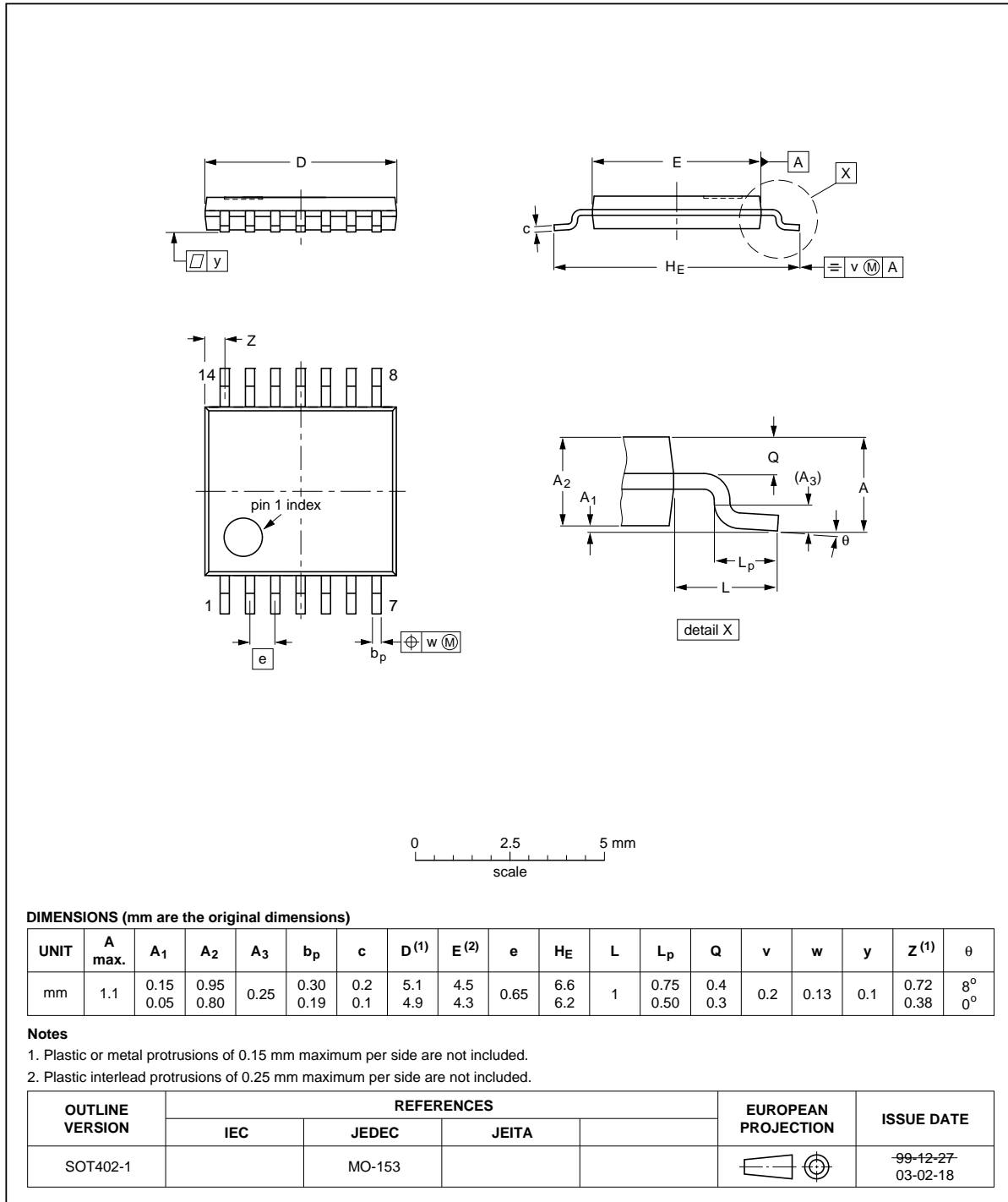
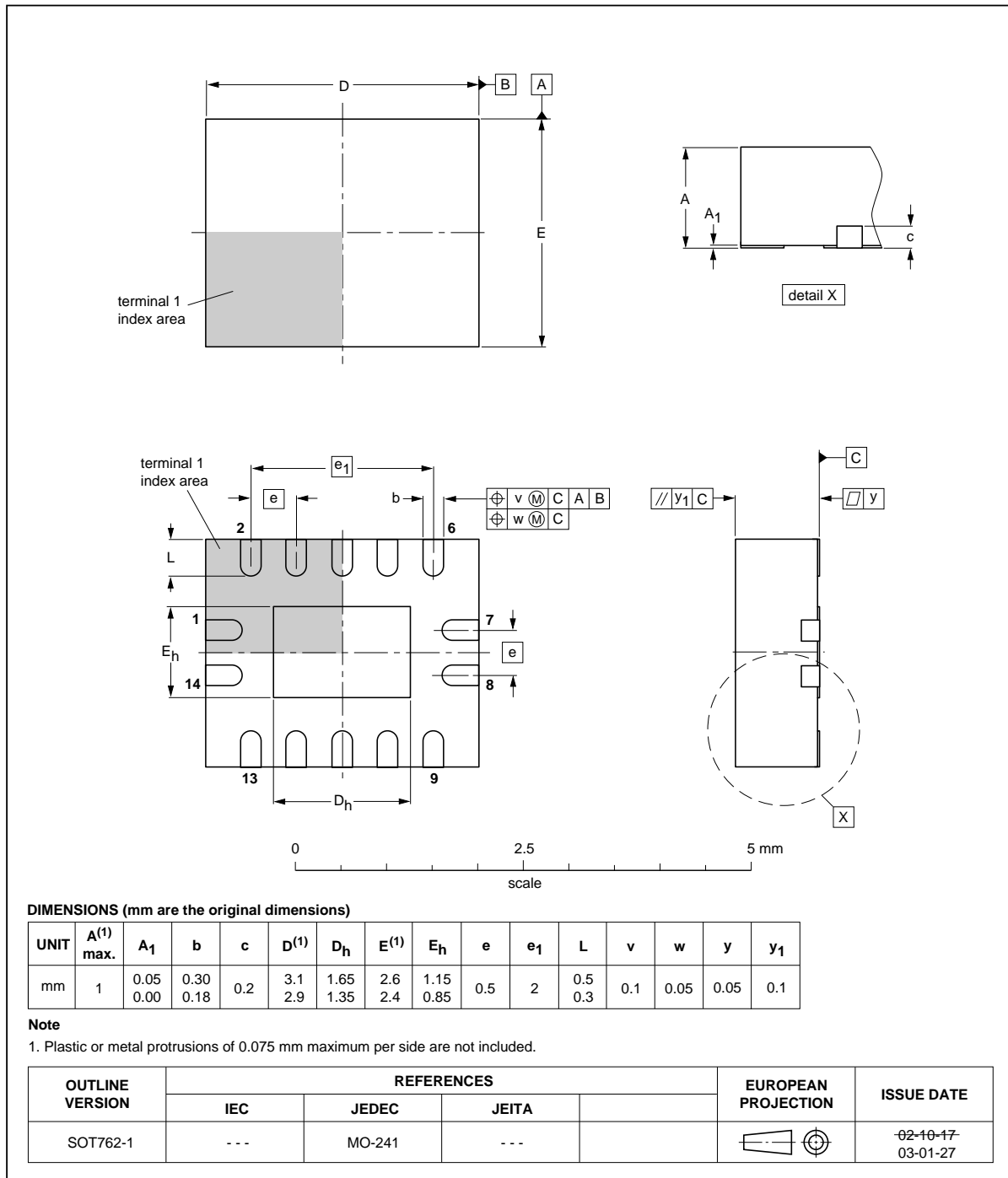


Fig 18. Package outline SOT402-1 (TSSOP14)

**DHVQFN14: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 x 3 x 0.85 mm SOT762-1**



**Fig 19. Package outline SOT762-1 (DHVQFN14)**



## 17. Abbreviations

Table 11. Abbreviations

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
LSTTL	Low-power Schottky Transistor-Transistor Logic
MM	Machine Model
MIL	Military

## 18. Revision history

Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT14_Q100 v.4	20130419	Product data sheet	-	74HC_HCT14_Q100 v.3
Modifications:	<ul style="list-style-type: none"> <li>74HCT14N-Q100 removed.</li> </ul>			
74HC_HCT14_Q100 v.3	20130410	Product data sheet	-	74HC_HCT14_Q100 v.2
Modifications:	<ul style="list-style-type: none"> <li>74HC14N-Q100 and 74HCT14N-Q100 added.</li> </ul>			
74HC_HCT14_Q100 v.2	20120810	Product data sheet	-	74HC_HCT14_Q100 v.1
Modifications:	<ul style="list-style-type: none"> <li><a href="#">Figure 15</a> added (typical K-factor for relaxation oscillator).</li> </ul>			
74HC_HCT14_Q100 v.1	20120709	Product data sheet	-	-

## 19. Legal information

### 19.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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